TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

## 2SK2843

# Chopper Regulator, DC-DC Converter and Motor Drive Applications

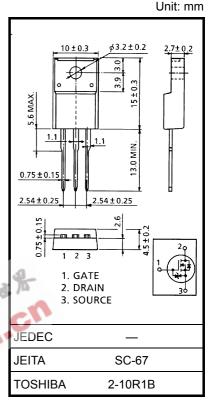
• Low drain-source ON resistance :  $RDS (ON) = 0.54 \Omega (typ.)$ • High forward transfer admittance :  $|Y_{fs}| = 9.0 S (typ.)$ 

• Low leakage current  $: I_{DSS} = 100 \mu A \text{ (max) (V}_{DS} = 600 \text{ V)}$ 

• Enhancement mode :  $V_{th} = 2.0 \sim 4.0 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$ 

#### **Absolute Maximum Ratings (Ta = 25°C)**

Characteristics		Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	600	V	
Drain-gate voltage (R <sub>GS</sub> = 20 kΩ)		$V_{DGR}$	600	V	
Gate-source voltage		$V_{GSS}$	±30	V	
Drain current	DC (Note 1)	ID	10	Α	
	Pulse (Note 1)	ulse (Note 1) I <sub>DP</sub>		Α	
Drain power dissipation (Tc = 25°C)		$P_{D}$	45	W	
Single pulse avalanche energy (Note 2)		E <sub>AS</sub>	363	mJ	
Avalanche current		I <sub>AR</sub>	10	A	
Repetitive avalanche energy (Note 3)		E <sub>AR</sub>	5.0	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature range		T <sub>stg</sub>	-55~150	°C	



Weight: 1.9 g (typ.)

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R <sub>th (ch-c)</sub>	2.78	°C / W
Thermal resistance, channel to ambient	R <sub>th (ch-a)</sub>	62.5	°C / W

Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2:  $V_{DD}$  = 90 V,  $T_{ch}$  = 25°C (initial), L = 6.36 mH,  $R_{G}$  = 25  $\Omega$ ,  $I_{AR}$  = 10 A

Note 3: Repetitive rating: pulse width limited by maximum channel temperature

This transistor is an electrostatic-sensitive device.

Please handle with caution.



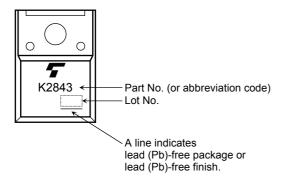
### Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	irrent	I <sub>GSS</sub>	V <sub>GS</sub> = ±25 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Gate-source bre	eakdown voltage	V (BR) GSS	I <sub>G</sub> = ±10 μA, V <sub>DS</sub> = 0 V	±30	_	_	V
Drain cut-off cu	rrent	I <sub>DSS</sub>	V <sub>DS</sub> = 600 V, V <sub>GS</sub> = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V (BR) DSS	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0 V	600	_	_	V
Gate threshold v	voltage	$V_{th}$	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA	2.0	_	4.0	V
Drain-source O	N resistance	R <sub>DS</sub> (ON)	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A	_	0.54	0.75	Ω
Forward transfer	r admittance	Y <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5 A	3.0	9.0	_	S
Input capacitano	e	C <sub>iss</sub>		_	2040	_	
Reverse transfe	r capacitance	C <sub>rss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	230	_	pF
Output capacitance		Coss		_	590	_	
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = V_{OUT}$ $V_{GS} = V_{OUT}$ $V_{CG} = V_{OUT}$ $R_{L} = 40\Omega$	_	22	_	
	Turn-on time	t <sub>on</sub>		_	58	_	
	Fall time	t <sub>f</sub>	$ ho_{ m D}$ $ ho_{ m DD}$	. –	36	_	ns
	Turn-off time	t <sub>off</sub>	Duty $\leq$ 1%, $t_{\rm W} = 10 \mu \rm s$	0-	190	_	
Total gate charg plus gate-drain)		Qg	a 3 cm.	_	45	_	
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx 400 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 10 \text{ A}$	_	25	_	nC
Gate-drain ("mil	te-drain ("miller") Charge Q <sub>gd</sub>		_	20	_		

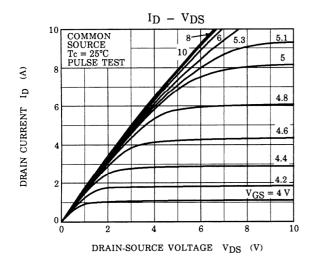
## Source-Drain Ratings and Characteristics (Ta = 25°C)

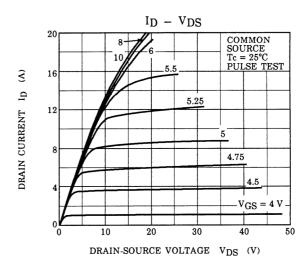
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I <sub>DR</sub>	_	_	_	10	Α
Pulse drain reverse current (Note 1)	I <sub>DRP</sub>	_	_	_	40	А
Forward voltage (diode)	V <sub>DSF</sub>	I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V	_	_	-1.7	V
Reverse recovery time	t <sub>rr</sub>	I <sub>DR</sub> = 10 A, V <sub>GS</sub> = 0 V		1300		ns
Reverse recovery charge	Q <sub>rr</sub>	dl <sub>DR</sub> / dt = 100 A / μs	1	16	1	μC

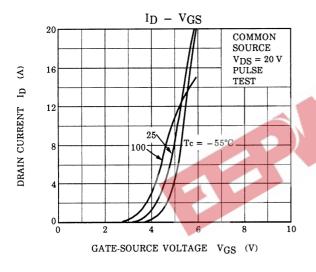
### Marking

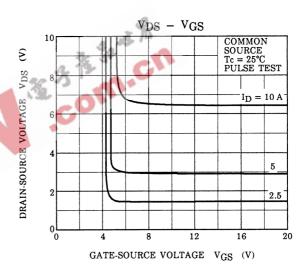


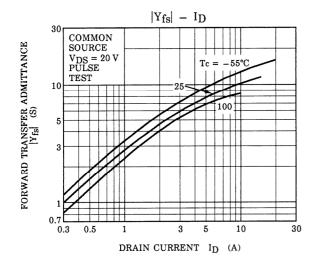
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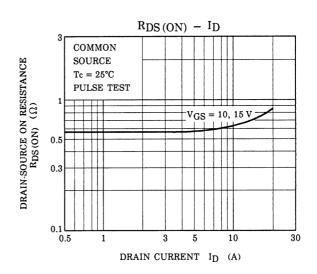




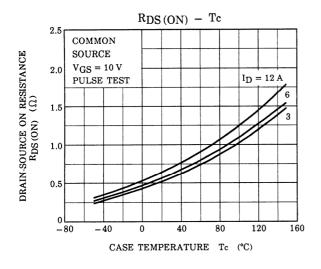


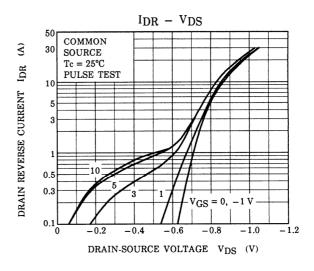


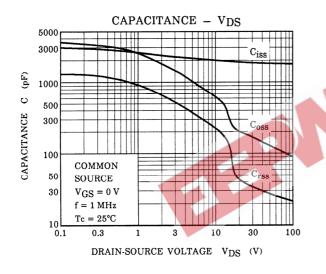


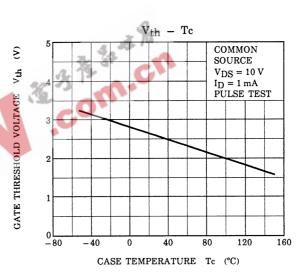


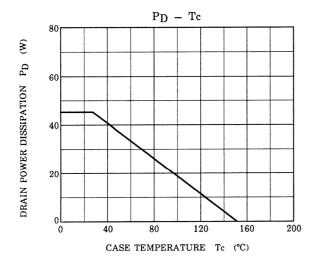
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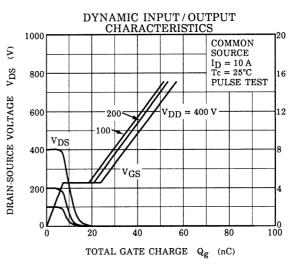




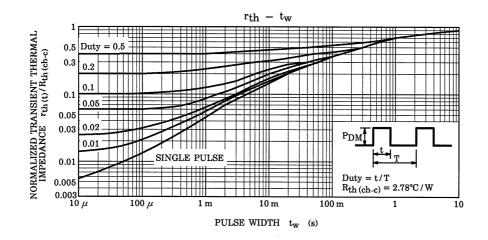


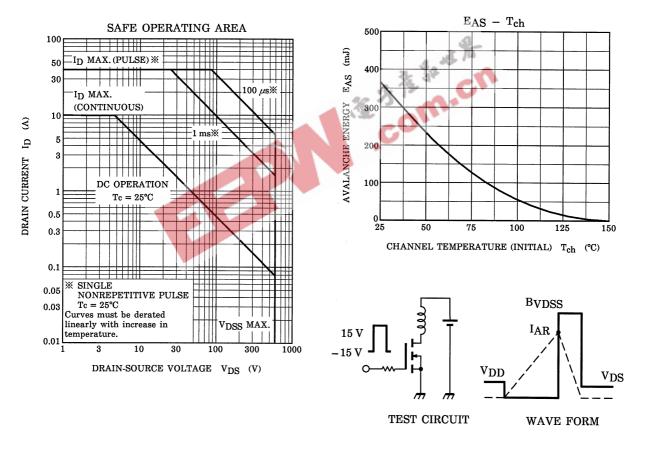






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$$R_G = 25 \Omega$$
  
 $V_{DD} = 90 \text{ V}, L = 6.36 \text{ mH}$ 

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$$EAS = \frac{1}{2} \cdot L \cdot I^{2} \cdot \left( \frac{BVDSS}{BVDSS - VDD} \right)$$

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